

02-16-01

A

Docket No. 4653/PDC/V

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application
 Assistant Commissioner for Patents
 Washington, D.C. 20231

Re: Inventor(s): Daniel I. SOME; Silviu REINHORN; Gilad ALMOGY
 Title: LASER SCANNING WAFER INSPECTION USING NONLINEAR OPTICAL PHENOMENA

Transmitted herewith is the patent application identified above, including:

- ☒ Specification, claims and abstract, totaling 17 pages.
- ☒ Drawings totaling 4 pages, Formal ☒ Informal.
- ☒ Executed Declaration and Power of Attorney.
- ☒ Assignment of the invention to Applied Materials, Inc.
- ☒ Assignment Recordation Cover Sheet
- ☒ Information Disclosure Statement, Form PTO-1449 and references

FEE CALCULATION

Fee Items	Claims Filed	Included With Basic Fee	Extra Claims	Fee Rate	Total
Total Claims	-34-	- 20 =	-14-	X \$18.00	-\$252.00-
Independent Claims	-3-	- 3 =	-0-	X \$78.00	-0-
Basic Filing Fee				\$710.00	\$710.00
TOTAL FEES					\$962.00

☒ The Commissioner is hereby authorized to charge \$962.00 to Deposit Account No 50-1074

☒ The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment to Deposit Account No. 50-1074. A duplicate copy of this transmittal is enclosed.

☒ Please address all future correspondence to:

PATENT COUNSEL
 APPLIED MATERIALS, INC.
 Legal Affairs Department
 P.O. BOX 450A
 Santa Clara, CA. 95052

I hereby certify that this correspondence is being deposited with the United States Postal Service as express mail in an envelope addressed to: Box Patent Application, Assistant Commissioner for Patents, Washington, D C 20231

Express Mail Receipt No EL66180554745

Date of Deposit 2-14-2001

Signature Boch Mulyahy

Respectfully submitted,

Robert W. Mulyahy

Robert W. Mulyahy
 Registration No. 25,436